

Product Specification

XBLW AO3422

N-Channel Enhancement Mode MOSFET

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Description

The AO3422 uses advanced trench technology to provide excellent RDS(ON), low gate charge and operation with gate voltages as low as 2.5V. This device is suitable for use as a Battery protection or in other Switching application.

General Features

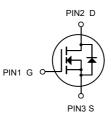
- ➢ VDS = 60V,ID = 4.5A
- RDS(ON) < 75mΩ @ VGS=10V</p>
- RDS(ON) < 90mΩ @ VGS=4.5V</p>

Application

- > High power and current handing capability
- Lead free product is acquired
- Surface mount package
- PWM applications
- Load switch
- Power management



SOT-23-3L



N-Channel MOSFET

Package Marking and Ordering Information

| Product Model | Package Type | Marking | Packing | Packing Qty |
|---------------|--------------|---------|---------|--------------|
| XBLW AO3422 | SOT-23-3L | ARDP | Таре | 3000Pcs/Reel |
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Absolute Maximum Ratings (TA=25°Cunless otherwise noted)

| Symbol | Parameter | Limit | Unit |
|----------------|--|------------|--------------|
| VDS | Drain-Source Voltage | 60 | V |
| Vgs | Gate-Source Voltage | ±20 | V |
| I _D | Drain Current-Continuous | 4.5 | А |
| Ы | Drain Current-Pulsed (Note 1) | 15 | A |
| PD | Maximum Power Dissipation | 8 | W |
| TJ,TSTG | Operating Junction and Storage Temperature Range | -55 To 150 | °C |
| Reja | Thermal Resistance, Junction-to-Ambient (Note 2) | 89 | °C /W |



Electrical Characteristics (TJ=25 °C, unless otherwise noted)

| Symbol | Parameter | Conditions | Min. | Тур. | Max. | Unit |
|---------------------|--|--|------|------|------|------|
| BV _{DSS} | Drain-Source Breakdown Voltage | V _{GS} =0V , I _D =250uA | 60 | | | V |
| D | Static Drain-Source On-Resistance ² | V _{GS} =10V , I _D =5A | | 70 | 75 | mΩ |
| R _{DS(ON)} | Static Drain-Source On-Resistance- | V _{GS} =4.5V , I _D =5A | | 80 | 90 | |
| $V_{GS(th)}$ | Gate Threshold Voltage | $V_{GS}=V_{DS}$, $I_D=250 uA$ | 1.2 | | 2.5 | V |
| laas | Drain-Source Leakage Current | V _{DS} =48V , V _{GS} =0V , T _J =25°C | | | 1 | uA |
| IDSS | | V _{DS} =48V , V _{GS} =0V , T _J =55°C | | | 5 | |
| lgss | Gate-Source Leakage Current | $V_{GS}=\pm 20V$, $V_{DS}=0V$ | | | ±100 | nA |
| gfs | Forward Transconductance | V _{DS} =5V , I _D =5A | | 7 | | S |
| Qg | Total Gate Charge (10V) | V _{DS} =12V , V _{GS} =10V , I _D =5A | | 5.5 | | |
| Qgs | Gate-Source Charge | | | 1.8 | | nC |
| Q _{gd} | Gate-Drain Charge | | | 2.4 | | |
| T _{d(on)} | Turn-On Delay Time | | | 6 | | |
| Tr | Rise Time | V _{DD} =12V , V _{GS} =10V , R _G =3.3Ω I _D =5A | | 10 | | |
| T _{d(off)} | Turn-Off Delay Time | | | 15 | | ns |
| T _f | Fall Time | | | 7 | | |
| Ciss | Input Capacitance | | | 695 | | |
| Coss | Output Capacitance | V _{DS} =15V , V _{GS} =0V , f=1MHz | | 148 | | pF |
| Crss | Reverse Transfer Capacitance | | | 7 | | |

Diode Characteristics

| Symbol | Parameter | Conditions | Min. | Тур. | Max. | Unit |
|-----------------|--|---|------|------|------|------|
| ls | Continuous Source Current ^{1,5} | | | | 17 | А |
| lsм | Pulsed Source Current ^{2,5} | −−−V _G =V _D =0V , Force Current | | | 50 | А |
| V _{SD} | Diode Forward Voltage ² | V _{GS} =0V , I _S =1A , TJ=25°C | | | 1.2 | V |

Note :

2.The data tested by pulsed , pulse width $\,\leq\,$ 300us , duty cycle $\,\leq\,$ 2%

3. The EAS data shows Max. rating . The test condition is $V_{\text{DD}}\text{=}25\text{V}, V_{\text{GS}}\text{=}10\text{V}, \text{L=}0.1\text{mH}, \text{I}_{\text{AS}}\text{=}15\text{A}$

4.The power dissipation is limited by 150°C junction temperature

5. The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.

^{1.} The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.



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Typical Characteristics

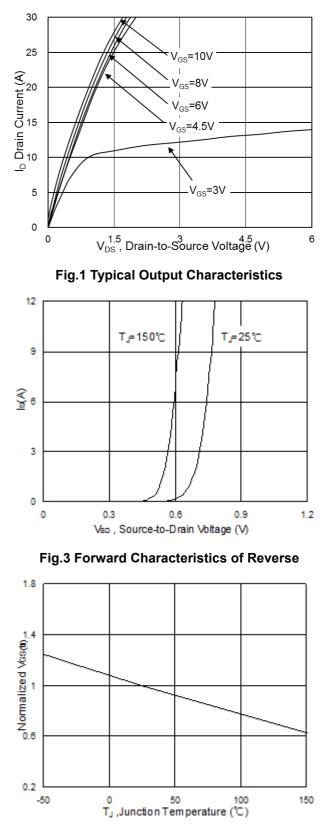


Fig.5 Normalized V_{GS(th)} vs. T_J

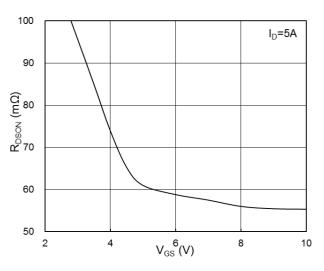


Fig.2 On-Resistance vs. Gate-Source Voltage

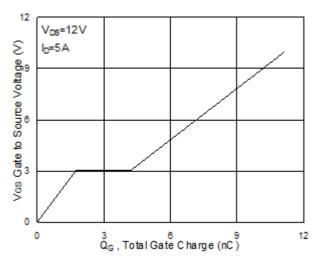


Fig.4 Gate-Charge Characteristics

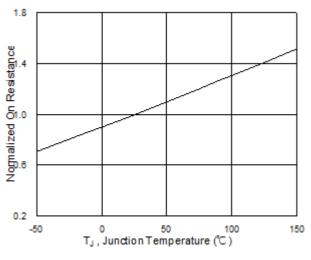


Fig.6 Normalized R_{DSON} vs. T_J



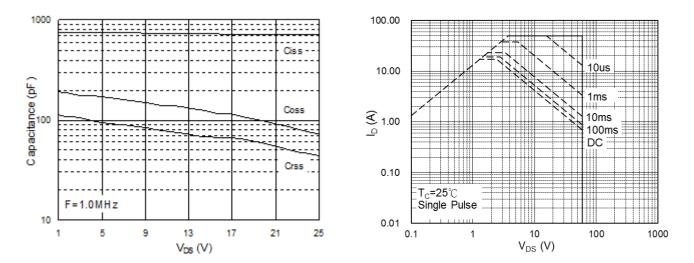


Fig.7 Capacitance

Fig.8 Safe Operating Area

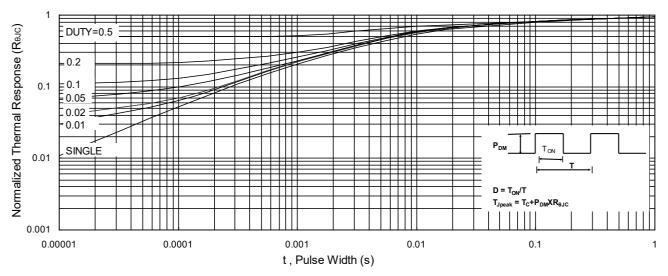
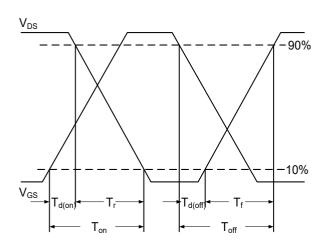
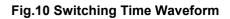
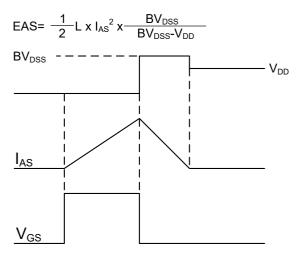
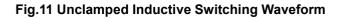


Fig.9 Normalized Maximum Transient Thermal Impedance





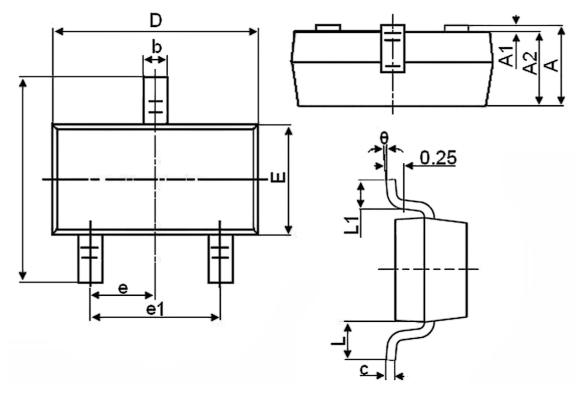






Package Information

SOT23-3L



| Symbol | Dimensions in Millimeters | | |
|--------|---------------------------|----------|--|
| | MIN. | MAX. | |
| A | 1.050 | 1.250 | |
| A1 | 0.000 | 0.100 | |
| A2 | 1.050 | 1.150 | |
| b | 0.300 | 0.500 | |
| с | 0.100 | 0.200 | |
| D | 2.800 | 3.000 | |
| E | 1.500 | 1.700 | |
| E1 | 2.650 | 2.950 | |
| е | | 0.950TYP | |
| e1 | 1.800 | 2.000 | |
| L | | 0.550REF | |
| L1 | 0.300 | 0.600 | |
| θ | 0° | 8° | |





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